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FIG. 1

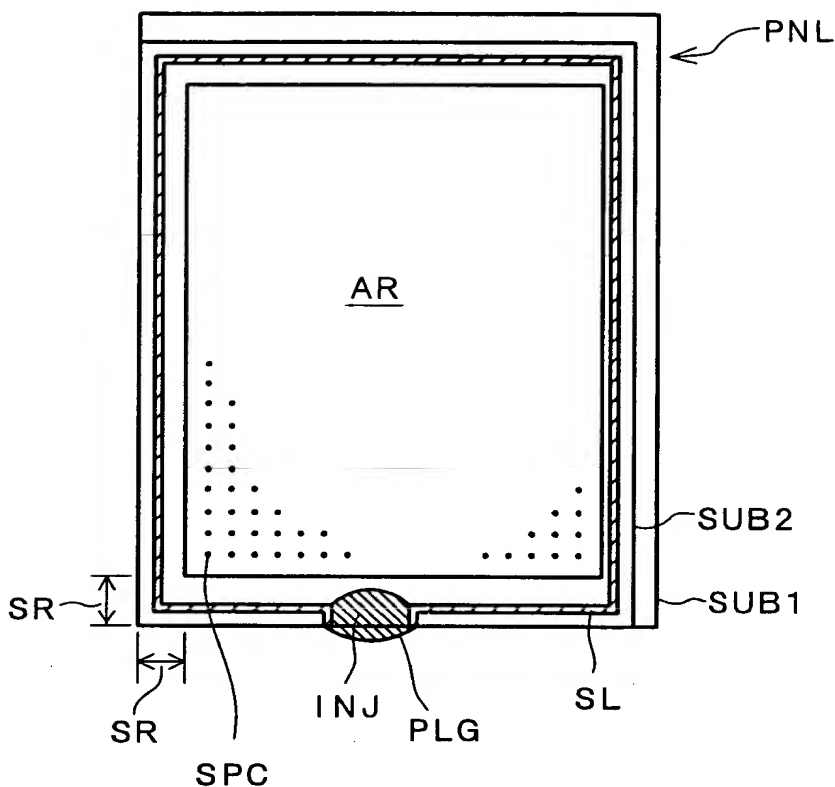
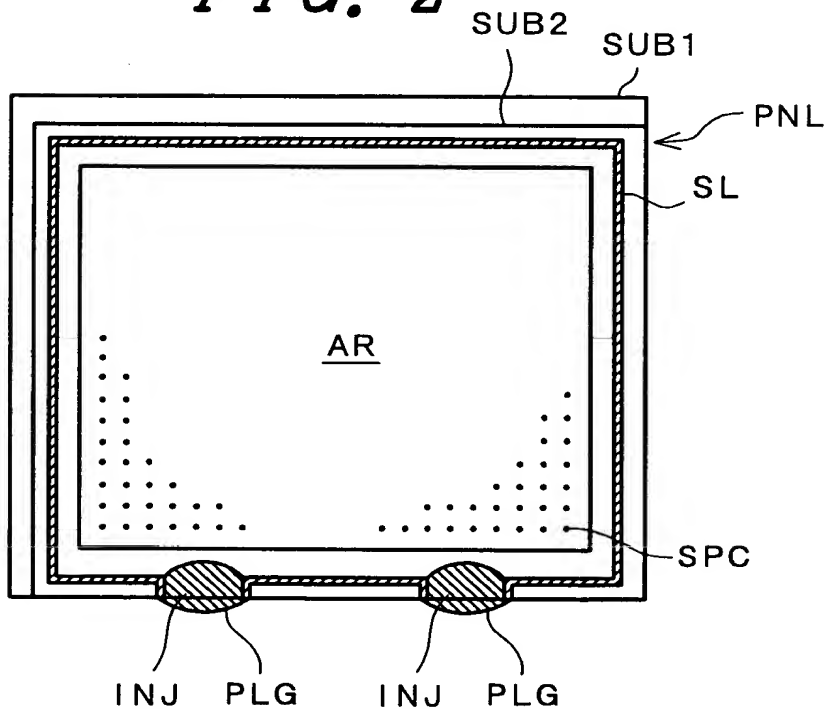


FIG. 2





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# FIG. 3

## MEASUREMENT CONDITIONS OF GC/MS

ANALYZER	M7200GC/MS
CONDITIONS OF GAS CHROMATOGRAPH (GC)	
COLUMN USED DB-5MS	0.25 mm $\phi$ x 30 m
CAPILLARY COLUMN SIZE	
CARRIER GAS HELIUM	
TEMPERATURE OF INJECTING PORT	260°C
COLUMN TEMPERATURE	FROM 100°C TO 280°C (TEMPERATURE INCREASE RATE: 5°C/MINUTE)
TRANSFER LINE TEMPERATURE	250°C
CONDITIONS OF GAS SPECTROMETER (MS)	
RANGE OF MASS NUMBER TO BE M/Z: 40-650 MEASURED	
ION SOURCE TEMPERATURE	230°C
IONIZING METHOD	ELECTRON IMPACT (EI) METHOD

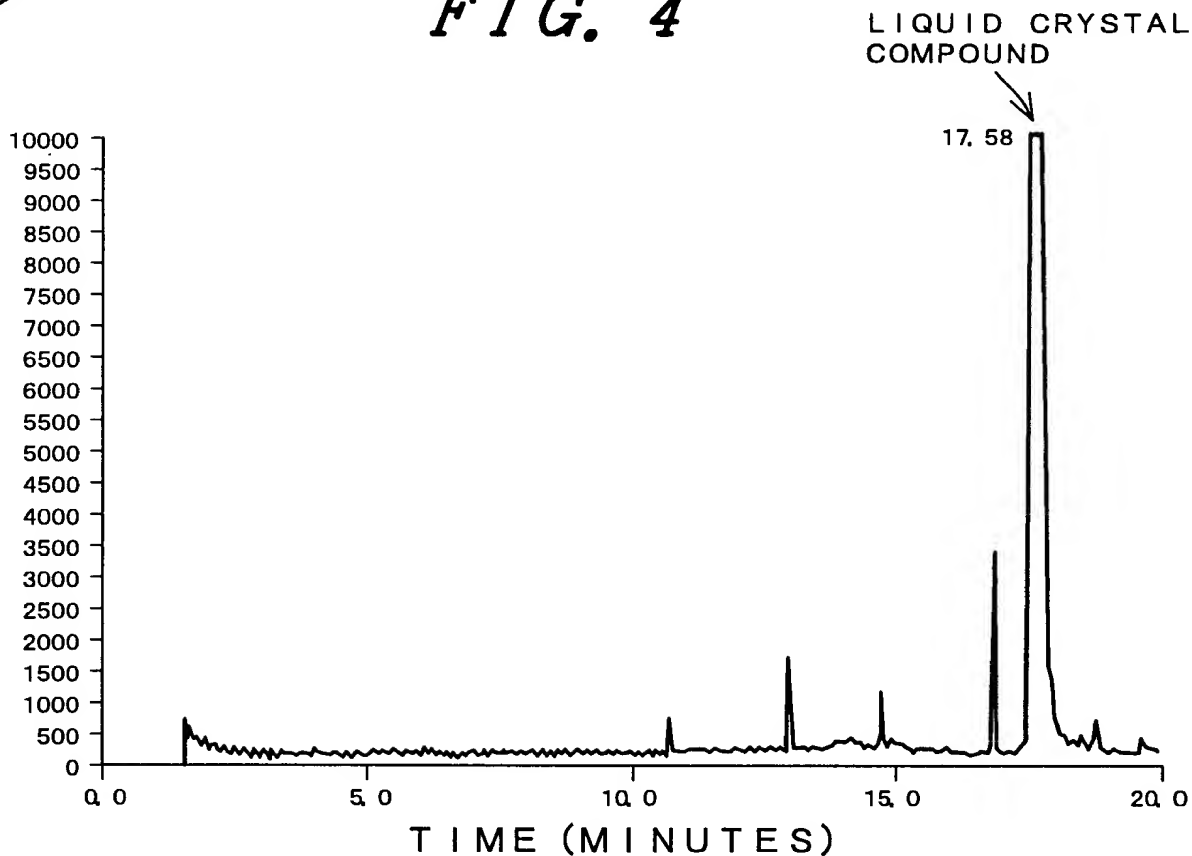


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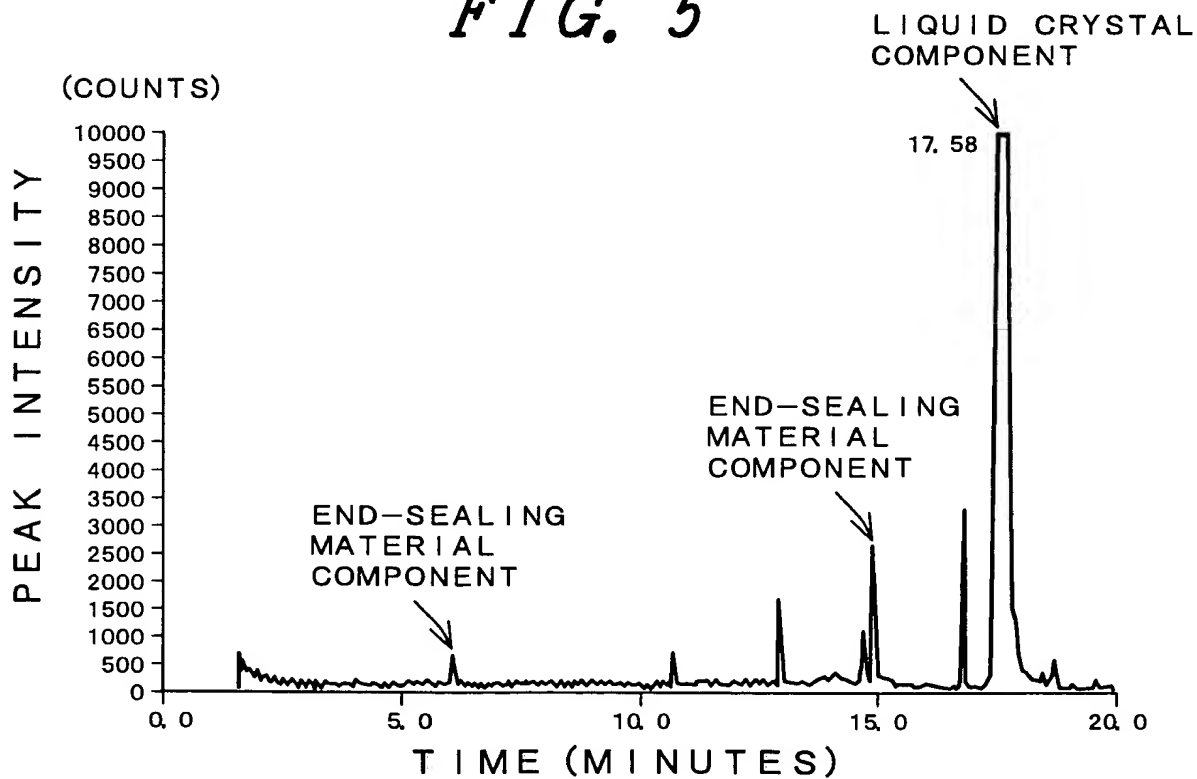
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*FIG. 4*



*FIG. 5*



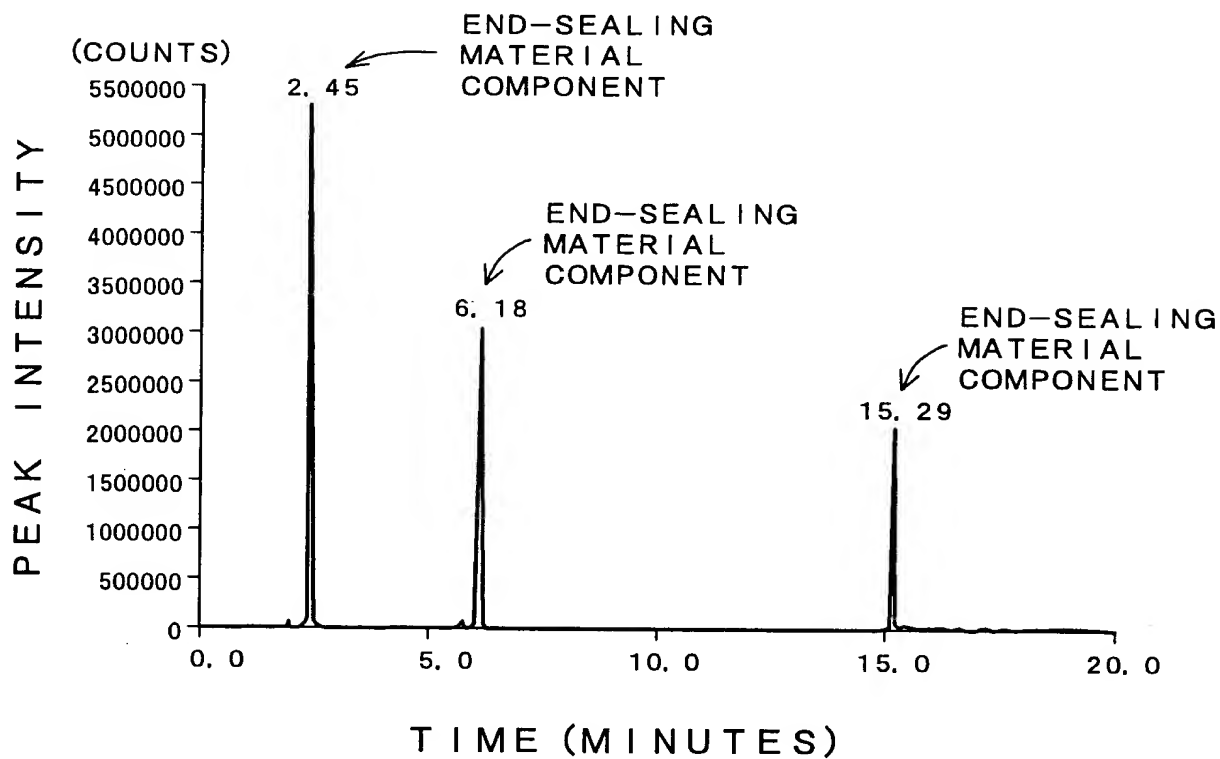


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*FIG. 6*





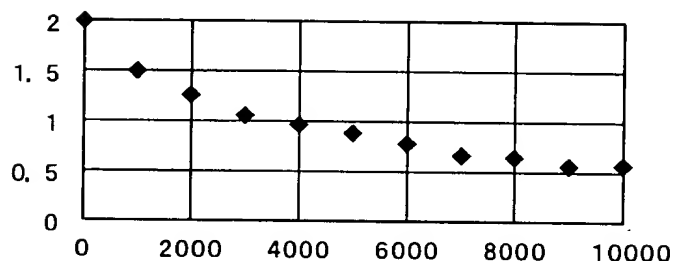
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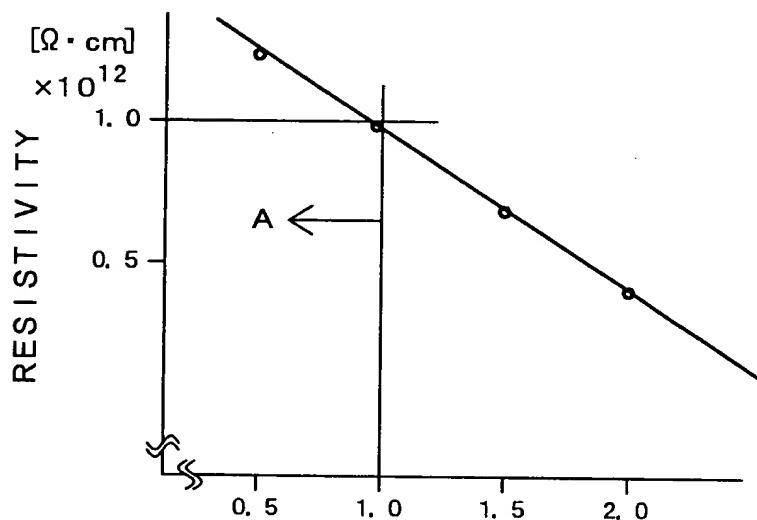
FIG. 7

AMOUNT OF CONSTITUTENT  
COMPONENTS OF END-  
SEALING MATERIAL WITH  
RESPECT TO PEAK AREA  
(10,000) OF LIQUID  
CRYSTAL COMPOUND



ACCUMULATED ULTAVIOLET-  
LIGHT AMOUNT (mJ/cm)

FIG. 8

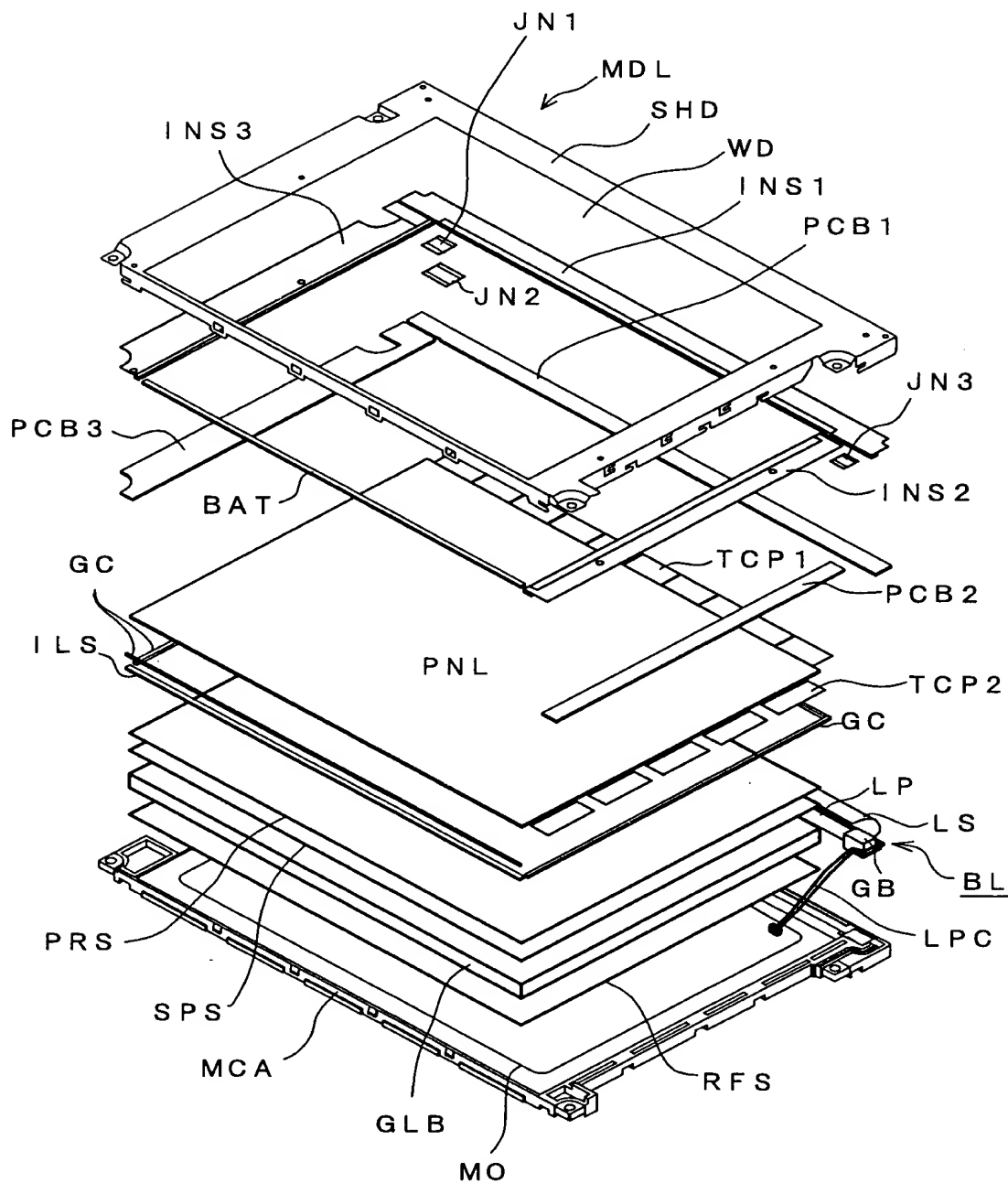


AMOUNT OF CONSTITUTENT  
COMPONENTS OF END-  
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RESPECT TO PEAK AREA  
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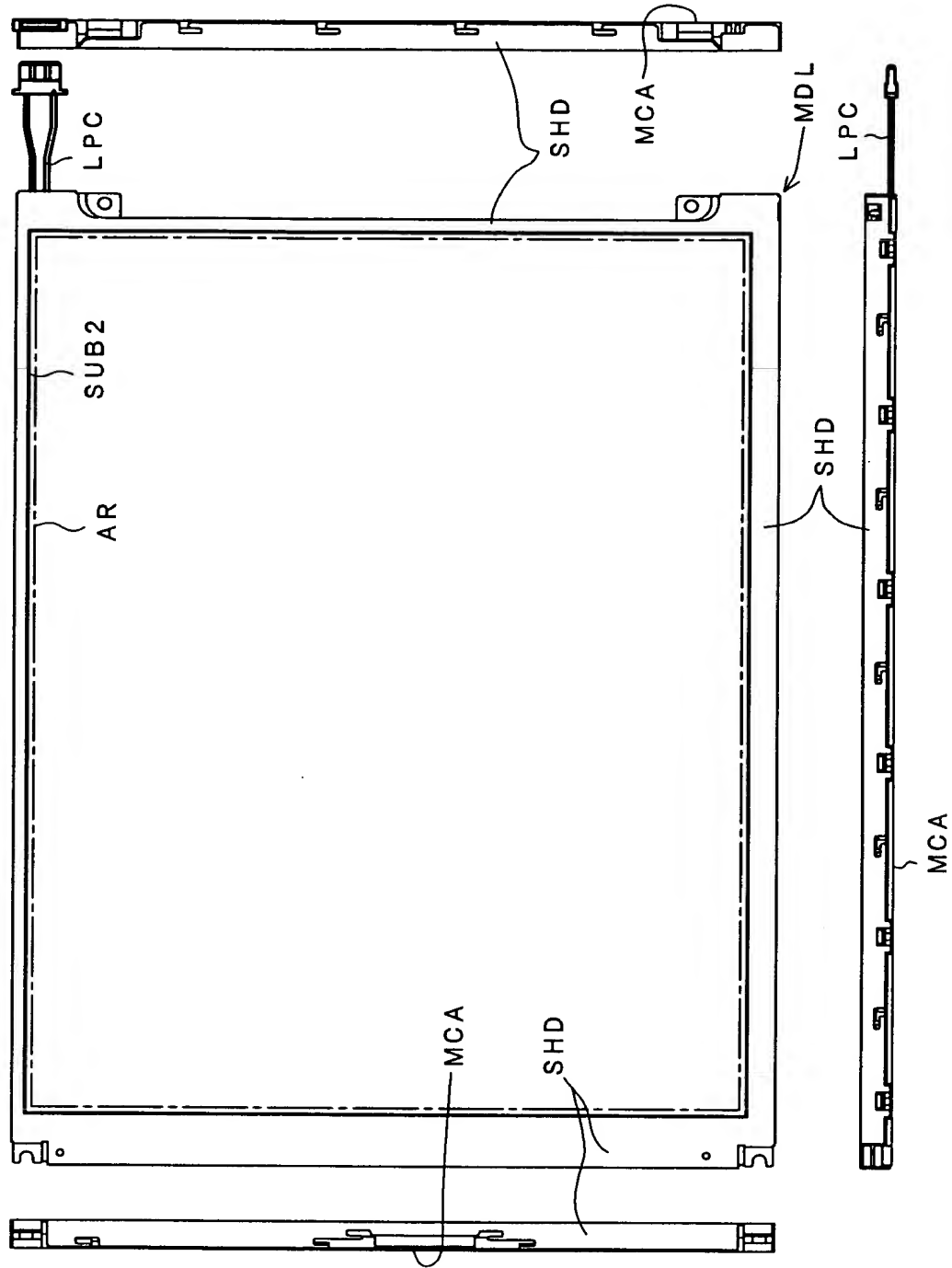
*FIG. 9*





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FIG. 10



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FIG. 11

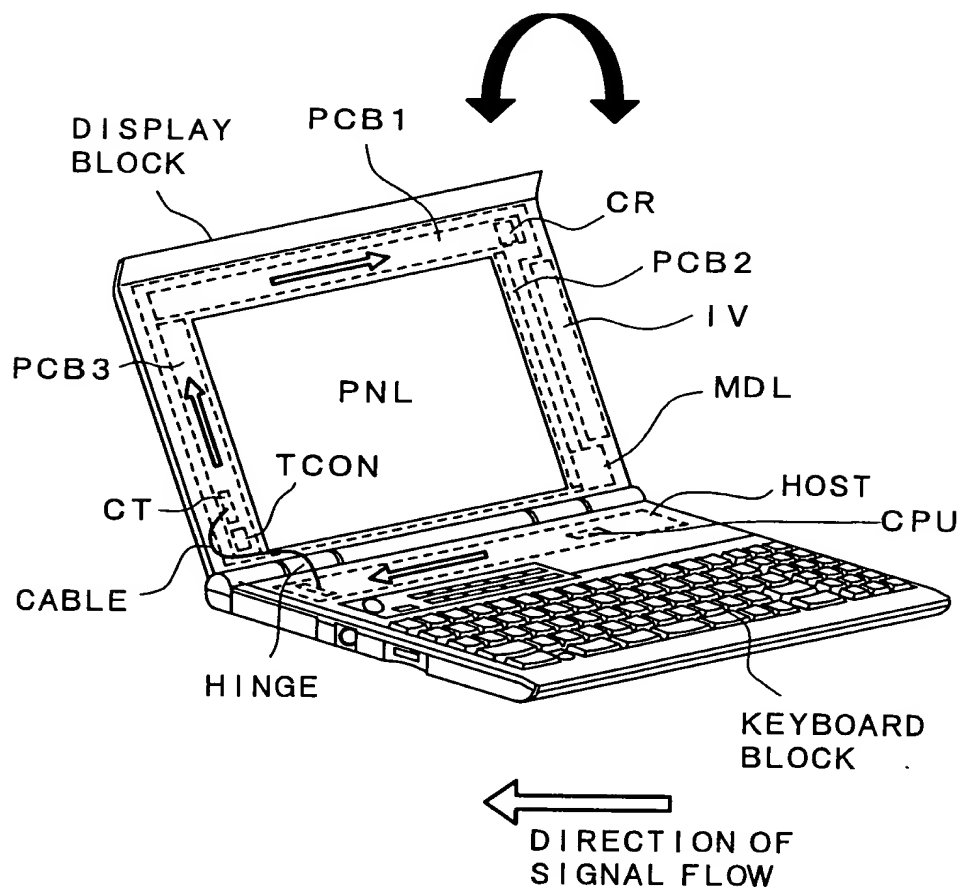
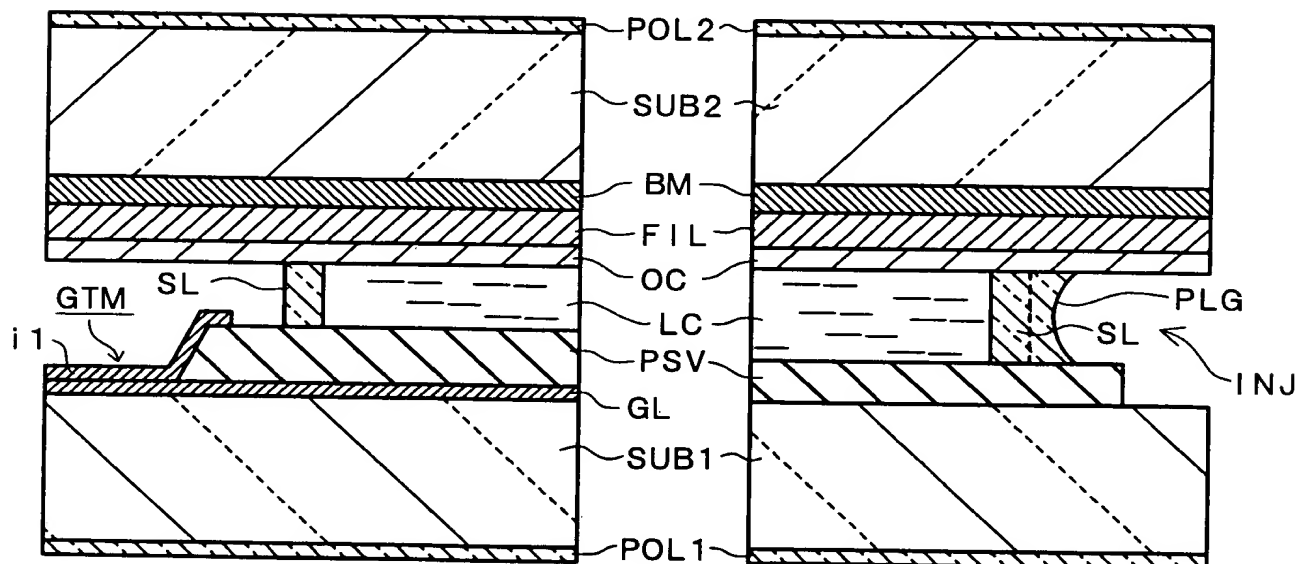


FIG. 12

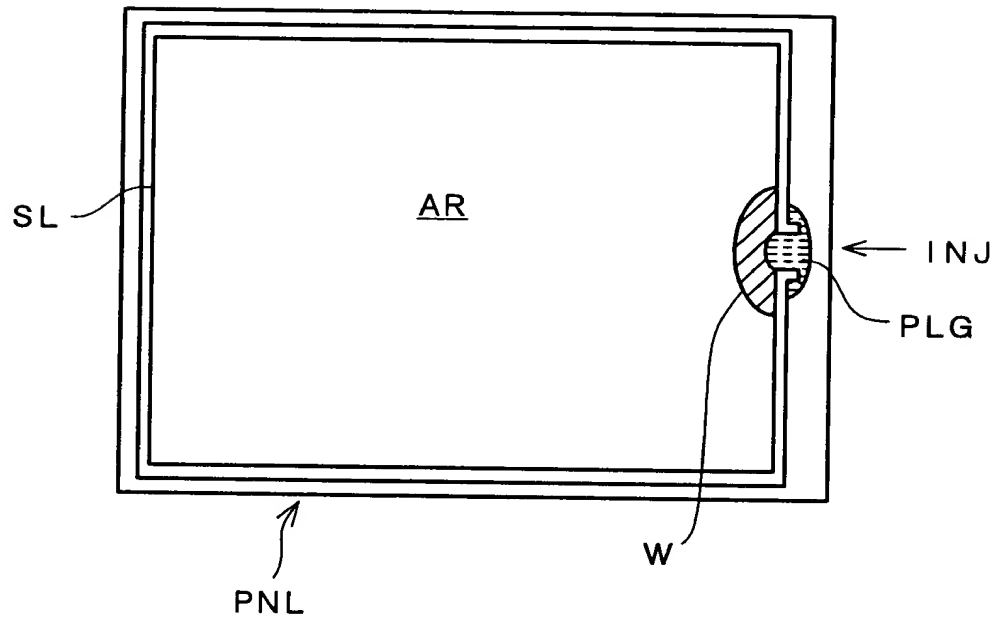






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*FIG. 13*



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# FIG. 14

